# 2.5V/3.3V, 14GHz ÷2 Clock Divider w/CML Output and Internal Termination

## Description

The NB7L32M is an integrated ÷2 divider with differential clock inputs and asynchronous reset.

Differential clock inputs incorporate internal 50  $\Omega$  termination resistors and accept LVPECL (Positive ECL), CML, or LVDS. The high frequency reset pin is asserted on the rising edge. Upon power-up, the internal flip-flops will attain a random state; the reset allows for the synchronization of multiple NB7L32M's in a system.

The differential 16 mA CML output provides matching internal  $50\,\Omega$  termination which guarantees 400 mV output swing when externally receiver terminated  $50\,\Omega$  to  $V_{CC}$  (See Figure 15).

The device is housed in a small 3x3 mm 16 pin QFN package.

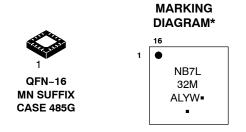
#### **Features**

- Maximum Input Clock Frequency 14 GHz Typical
- 200 ps Max Propagation Delay
- 30 ps Typical Rise and Fall Times
- < 0.5 ps Maximum (RMS) Random Clock Jitter
- Operating Range:  $V_{CC} = 2.375 \text{ V}$  to 3.465 V with  $V_{EE} = 0 \text{ V}$
- CML Output Level (400 mV Peak-to-Peak Output), Differential Output Only
- 50  $\Omega$  Internal Input and Output Termination Resistors
- Functionally Compatible with Existing 2.5 V / 3.3 V LVEL, LVEP, EP, and SG Devices
- These are Pb-Free Devices



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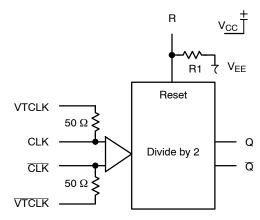
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A = Assembly Location

L = Wafer Lot Y = Year W = Work Week ■ Pb-Free Package

### **FUNCTIONAL BLOCK DIAGRAM**



## TRUTH TABLE

CLK	CLK	R	Q	Q
х	х	Н	L	Н
Z	W	L	÷2	÷2

Z = LOW to HIGH Transition W = HIGH to LOW Transition

x = Don't Care

## **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 9 of this data sheet.

<sup>\*</sup>For additional marking information, refer to Application Note AND8002/D.

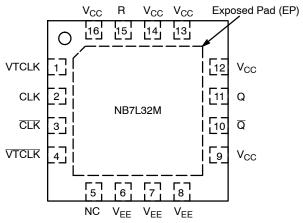


Figure 1. Pin Configuration (Top View)

## **Table 1. PIN DESCRIPTION**

Pin	Name	I/O	Description	
1	VTCLK	-	Internal 50 $\Omega$ termination pin. In the differential configuration when the inputermination pin (VTCLK, VTCLK) are connected to a common termination voltage or left open, and if no signal is applied on CLK/CLK input then the device will be susceptible to self–oscillation.	
2	CLK	ECL, CML, LVDS Input	Noninverted differential input. In the differential configuration when the input termination pin (VTCLK, VTCLK) are connected to a common termination voltage or left open and if no signal is applied on CLK/CLK input, then the device will be susceptible to self-oscillation.	
3	CLK	ECL, CML, LVDS Input	Inverted differential input. In the differential configuration when the input termination pin (VTCLK, VTCLK) are connected to a common termination voltage or left open and if no signal is applied on CLK/CLK input, then the device will be susceptible to self-oscillation.	
4	VTCLK	-	Internal 50 $\Omega$ termination pin. In the differential configuration when the input termination pin (VTCLK, VTCLK) are connected to a common termination voltage or left open and if no signal is applied on CLK/CLK input, then the device will be susceptible to self–oscillation.	
5	NC	-	No connect. NC pin must be left open.	
6, 7, 8	V <sub>EE</sub>	=	Negative supply voltage.	
9, 12, 13, 14, 16	V <sub>CC</sub>	-	Positive supply voltage.	
10	Q	CML Output	Inverted differential output. Typically terminated with 50 $\Omega$ resistor to $V_{CC}$ .	
11	Q	CML Output	Noninverted differential output. Typically terminated with 50 $\Omega$ resistor to V <sub>CC</sub> .	
15	R	LVTTL/LVCMOS	Reset Input. Internal pulldown to 75 k $\Omega$ to V <sub>EE</sub> .	
-	EP	-	Exposed Pad. The thermally exposed pad (EP) on package bottom (see case drawing) must be attached to a heat–sinking conduit. EP is electrically isolated from $V_{CC}$ and $V_{EE}$ .	

**Table 2. ATTRIBUTES** 

Characterist	Value					
Internal Input Pulldown Resistor	R1	75 kΩ				
ESD Protection	Human Body Model Machine Model	> 500 V > 30 V				
Moisture Sensitivity (Note 1)	QFN-16	Level 1				
Flammability Rating	Oxygen Index: 28 to 34	UL 94 V-0 @ 0.125 in				
Transistor Count	349					
Meets or exceeds JEDEC Spec EIA/JESD78 IC Latchup Test						

<sup>1.</sup> For additional information, see Application Note AND8003/D.

**Table 3. MAXIMUM RATINGS** 

Symbol	Parameter	Condition 1	Condition 2	Rating	Unit
V <sub>CC</sub>	Positive Power Supply	V <sub>EE</sub> = 0 V		3.6	V
V <sub>EE</sub>	Negative Power Supply	V <sub>CC</sub> = 0 V		-3.6	V
VI	Positive Input Negative Input	V <sub>EE</sub> = 0 V V <sub>CC</sub> = 0 V	$\begin{array}{c} V_I \leq V_{CC} \\ V_I \geq V_{EE} \end{array}$	3.6 -3.6	V
V <sub>INPP</sub>	Differential Input Voltage			2.8	V
I <sub>IN</sub>	Input Current Through $R_T$ (50 $\Omega$ Resistor)	Static Surge		45 80	mA mA
I <sub>out</sub>	Output Current	Continuous Surge		25 50	mA mA
T <sub>A</sub>	Operating Temperature Range	QFN-16		-40 to +85	°C
T <sub>stg</sub>	Storage Temperature Range			-65 to +150	°C
$\theta_{JA}$	Thermal Resistance (Junction-to-Ambient) (Note 2)	0 lfpm 500 lfpm	QFN-16 QFN-16	41.6 35.2	°C/W °C/W
$\theta_{JC}$	Thermal Resistance (Junction-to-Case)	1S2P	QFN-16	4.0	°C/W
T <sub>sol</sub>	Wave Solder Pb-Free	<3 sec @ 260°C		265	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

<sup>2.</sup> JEDEC standard multilayer board – 1S2P (1 signal, 2 power) with 8 filled thermal vias under exposed pad.

Table 4. DC CHARACTERISTICS, CLOCK INPUTS, CML OUTPUTS  $V_{CC} = 2.375 \text{ V}$  to 3.465 V,  $V_{EE} = 0 \text{ V}$ ,

$T_A = -40^{\circ}C$ to	+85°C
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Symbol		Characteristic	Min	Тур	Max	Unit
I <sub>CC</sub>	Power Supply Current (Note 3)		50	65	80	mA
V <sub>OH</sub>	Output HIGH Voltage (Note 4)		V <sub>CC</sub> - 40	V <sub>CC</sub> - 10	V <sub>CC</sub>	mV
V <sub>OL</sub>	Output LOW Voltage (Note	4)	V <sub>CC</sub> - 500	V <sub>CC</sub> - 400	V <sub>CC</sub> – 300	mV
R <sub>TOUT</sub>	Internal Output Termination	Resistor	45	50	55	Ω
R <sub>Temp</sub> Coef	Internal I/O Termination Re	sistor Temperature Coefficient		6.38		mΩ/°C
DIFFERE	NTIAL CLK/CLK INPUT DR	IVEN SINGLE-ENDED (see Figure 9 and 11)				
V <sub>th</sub>	Input Threshold Reference	Voltage Range (Note 6)	1050		V <sub>CC</sub>	mV
V <sub>IH</sub>	Single-ended Input HIGH	/oltage	V <sub>th</sub> + 150		V <sub>CC</sub> + 300	mV
V <sub>IL</sub>	Single-ended Input LOW \	oltage on the state of the stat	V <sub>EE</sub>		V <sub>th</sub> – 150	mV
DIFFERE	NTIAL CLK/CLK INPUTS D	RIVEN DIFFERENTIALLY (see Figure 10 and 1	2)	•	•	
V <sub>IHD</sub>	Differential Input HIGH Vol	age	1200		V <sub>CC</sub> + 300	mV
V <sub>ILD</sub>	Differential Input LOW Volt	age	V <sub>EE</sub>		V <sub>CC</sub> – 75	mV
V <sub>CMR</sub>	Input Common Mode Rang	e (Differential Configuration, Note 7)	1125		V <sub>CC</sub>	mV
$V_{\text{ID}}$	Differential Input Voltage (\	(IHD - VILD)	150		2500	mV
I <sub>IH</sub>	Input HIGH Current	CLK/CLK (VTCLK/R/VTCLK/R Open)	0	30	100	μΑ
I <sub>IL</sub>	Input LOW Current	CLK/CLK(VTCLK/R/VTCLK/R Open)	-50	0	50	μΑ
R <sub>TIN</sub>	Internal Input Termination F	Resistor	45	50	55	Ω
LVTTL/L\	/CMOS RESET INPUT		-	-		-
VILL	Single-ended Input HIGH	/oltage	2000		Vcc	mV

V <sub>IH</sub>	Single-ended Input HIGH Voltage		2000		V <sub>CC</sub>	mV
V <sub>IL</sub>	Single-ended Input LOW Voltage		V <sub>EE</sub>		800	mV
I <sub>IH</sub>	Input HIGH Current	R	0	30	100	μΑ
I <sub>IL</sub>	Input LOW Current	R	0	10	100	μΑ

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

- 3. Input termination pins open and all outputs loaded with external  $R_L$  = 50  $\Omega$  receiver termination resistor.
- 4. CML outputs require R<sub>L</sub> = 50  $\Omega$  receiver termination resistors to V<sub>CC</sub> for proper operation. (See Figure 8)
- 5. Input and output parameters vary 1:1 with V<sub>CC</sub>.
- 6. V<sub>th</sub> is applied to the complementary input when operating in single-ended mode.
- 7. V<sub>CMR(MIN)</sub> varies 1:1 with V<sub>EE</sub>, V<sub>CMR</sub> max varies 1:1 with V<sub>CC</sub>. The V<sub>CMR</sub> range is referenced to the most positive side of the differential input signal.

Table 6. AC CHARACTERISTICS  $V_{CC} = 2.375 \text{ V}$  to 3.465 V,  $V_{EE} = 0 \text{ V}$  (Note 8)

			-40°C		25°C		85°C					
Symbol	Characteristic		Min	Тур	Max	Min	Тур	Max	Min	Тур	Max	Unit
V <sub>OUTPP</sub>	Output Voltage Amplitude (@ V <sub>INPF</sub> (See Figures 2, 3, 4, 5, and 6)	$f_{\text{in}} \le 7 \text{ GHz}$ $f_{\text{in}} \le 12 \text{ GHz}$	190 160	330 320		190 160	330 320		190 160	330 320		mV
f <sub>IN</sub>	Maximum Input Clock Frequency (See Figure 2)		12	14		12	14		12	14		GHz
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation Delay to Output Differential (See Figure 7)	CLK to Q R to Q	130 200	155 240	200 300	130 200	155 240	200 300	130 200	155 260	200 300	ps
t <sub>skew</sub>	Duty Cycle Skew (Note 9) Device-to-Device Skew (Note 12)			2 6	20 50		2 6	20 50		2 6	20 50	
t <sub>RR</sub>	Reset Recovery (See Figure 7)		300	135		300	135		300	135		ps
t <sub>PW</sub>	Minimum Pulse Width	R	500	210		500	210		500	210		ps
t <sub>JITTER</sub>	Random Clock Jitter (RMS) (Note 11)	f <sub>in</sub> ≤ 7 GHz f <sub>in</sub> = 12 GHz		0.13 0.14	0.5 0.5		0.13 0.14	0.5 0.5		0.13 0.14	0.5 0.5	ps
V <sub>INPP</sub>	Input Voltage Swing/Sensitivity (Differential Configuration) (Note 10	)	150		2500	150		2500	150		2500	mV
t <sub>r</sub>	Output Rise/Fall Times @ 1 GHz (20% - 80%)			30	45		30	45		30	45	ps

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

- 8. Measured by forcing  $V_{INPP(MIN)}$  from a 50% duty cycle clock source. All loading with an external  $R_L = 50 \Omega$  to  $V_{CC}$ . Input edge rates 40 ps (20% 80%).
- 9. Duty cycle skew is measured between differential outputs using the deviations of the sum of Tpw- and Tpw+ 1 GHz.
- 10. V<sub>INPP(MAX)</sub> cannot exceed V<sub>CC</sub> V<sub>EE</sub>. Input voltage swing is a single-ended measurement operating in differential mode.
- 11. Additive RMS jitter with 50% duty cycle input clock signal.
- 12. Device-to-device skew is measured between outputs under identical transition @ 1 GHz.

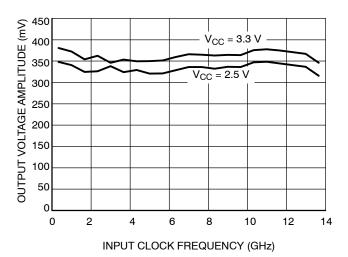


Figure 2. Output Voltage Amplitude ( $V_{OUTPP}$ ) versus Input Clock Frequency ( $f_{OUT}$ ) at Ambient Temperature ( $V_{INPP}$  = 150 mV)

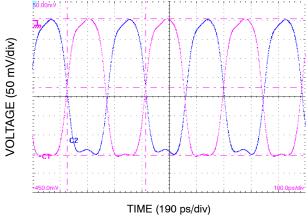


Figure 3. Typical Output Waveform with  $f_{IN}$  = 7 GHz(  $V_{CC}$  = 2.5 V,  $V_{INPP}$  = 400 mV, Room Temperature,  $V_{OUTPP}$  = 357 mV,  $t_r$  = 33 ps,  $t_f$  = 30 ps,  $t_{OUT}$  = 3.499 GHz)

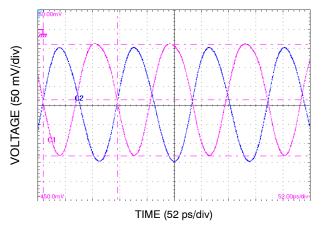


Figure 5. Typical Output Waveform with  $f_{IN}$  = 14 GHz( $V_{CC}$  = 2.5 V,  $V_{INPP}$  = 400 mV, Room Temperature,  $V_{OUTPP}$  = 292 mV,  $t_r$  = 25 ps,  $t_f$  = 27 ps,  $t_{OUT}$  = 7.01 GHz)

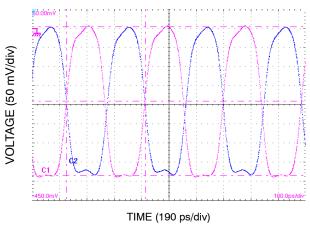


Figure 4. Typical Output Waveform with  $f_{\text{IN}}$  = 7 GHz(V<sub>CC</sub> = 3.3 V, V<sub>INPP</sub> = 400 mV, Room Temperature, V<sub>OUTPP</sub> = 387 mV, t<sub>r</sub> = 32 ps,  $t_{\text{f}}$  = 29.8 ps,  $f_{\text{OUT}}$  = 3.499 GHz)

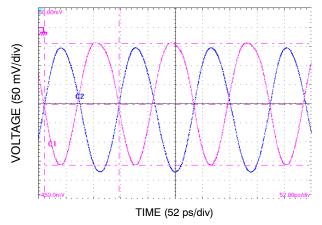


Figure 6. Typical Output Waveform with  $f_{IN} = 14$  GHz( $V_{CC} = 3.3$  V,  $V_{INPP} = 400$  mV, Room Temperature,  $V_{OUTPP} = 319$  mV, tr = 25 ps,  $t_f = 26$  ps,  $f_{OUT} = 7.01$  GHz)

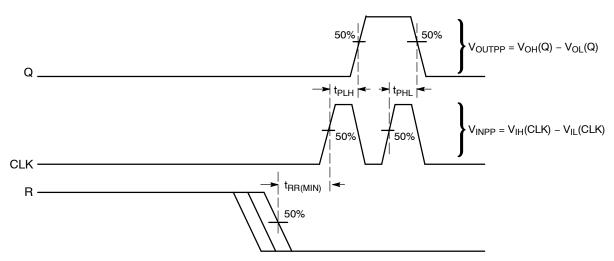


Figure 7. AC Reference Measurement (Timing Diagram)

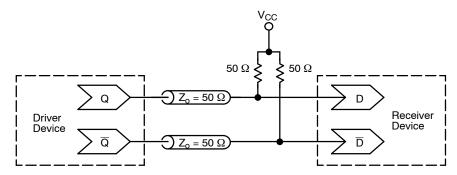
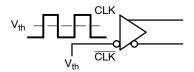


Figure 8. Typical Termination for Output Driver and Device Evaluation (See Application Note AND8073/D – Termination of CML Logic Devices.)



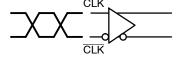


Figure 9. Differential Input Driven Single-Ended

Figure 10. Differential Inputs Driven Differentially

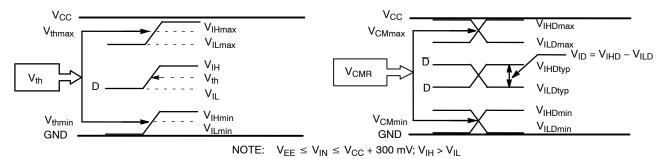


Figure 11. V<sub>th</sub> Diagram

Figure 12. V<sub>CMR</sub> Diagram

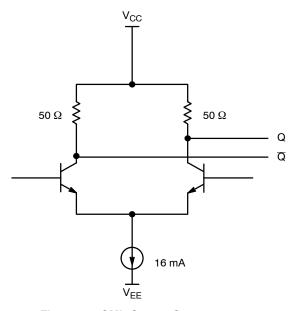


Figure 13. CML Output Structure

### **APPLICATION INFORMATION**

All NB7L32M inputs can accept PECL, CML, and LVDS signal levels. The limitations for differential input signal (LVDS, PECL, or CML) are minimum input swing of 150 mV and the maximum input swing of 2500 mV. Within these conditions, the input voltage can range from  $V_{CC}$  to 1.2 V. Examples interfaces are illustrated below in a 50  $\Omega$  environment (Z = 50  $\Omega$ ). For output termination and interface, refer to application note AND8020/D.

**Table 5. INTERFACING OPTIONS** 

Interfacing Options	Connections		
CML	Connect VTD and VTD to V <sub>CC</sub> (See Figure 14)		
LVDS	Connect VTD and VTD Together (See Figure 16)		
AC-COUPLED	Bias VTD and VTD Inputs within Common Mode Range (V <sub>CMR</sub> ) (See Figure 15)		
RSECL, PECL, NECL	Standard ECL Termination Techniques (See Figure 8)		

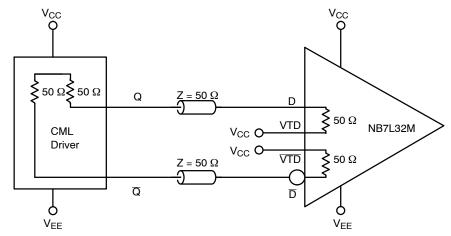
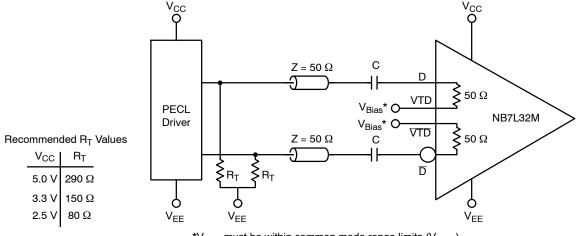


Figure 14. CML to NB7L32M Interface



 $^*\mbox{V}_{\mbox{\footnotesize Bias}}$  must be within common mode range limits (V\_{\mbox{\footnotesize CMR}})

Figure 15. PECL to NB7L32M Interface

## **APPLICATION INFORMATION**

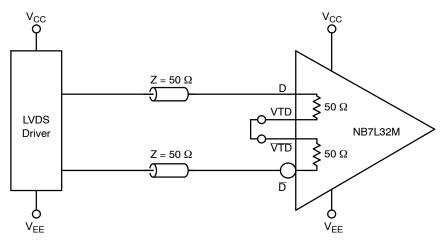


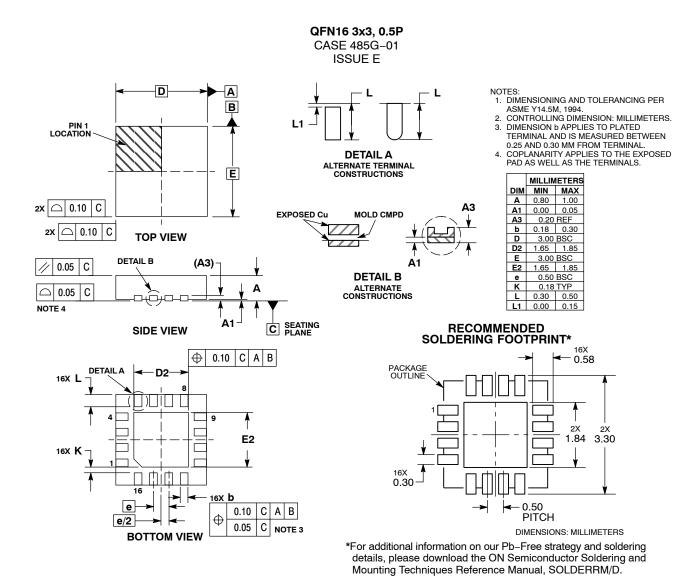
Figure 16. LVDS to NB7L32M Interface

# **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NB7L32MMNG	QFN-16 (Pb-Free)	123 Units / Rail
NB7L32MMNR2G	QFN-16 (Pb-Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS



The products described herein (NB7L32M), may be covered by U.S. patents including 6,362,644. There may be other patents pending.

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